SN74ACT16374Q-EP 16-BIT D-TYPE EDGE-TRIGGERED FLIP-FLOP WITH 3-STATE OUTPUTS

DL PACKAGE (TOP VIEW)

10E

1Q1 **2**

1Q2 3

GND ∏ 4

1Q3 **∏** 5

1Q4 🛮 6

V_{CC} [] 7

1Q5 🛮 8

1Q6 🛮 9

GND 10

1Q8 | 12

2Q1 1 13

2Q2 **1** 14

GND | 15

2Q3 1 16

V_{CC} 🛮 18

2Q5 **1** 19

2Q6∏ 20

GND 🛮 21

2Q7 **□** 22

23

24

2Q8 [

2OE [

2Q4 Π 17

1Q7 Π 11

SCAS679B - MAY 2002 - REVISED JULY 2002

48 1 1CLK

47**∏**1D1

46**∏**1D2

45∏GND

44**∏**1D3

43**∏**1D4

42 VCC

41 1D5

40 1D6

39 GND

38**∏**1D7

37**∏**1D8

36 2D1

35 1 2D2

34 I GND

33 D3 32 2D4

31 V_{CC}

30 **∏** 2D5

29 1 2D6

28 I GND

27 🛮 2D7

26 2D8

25 2CLK

Controlled Baseline

- One Assembly/Test Site, One Fabrication
- **Extended Temperature Performance of** -40°C to 125°C
- **Enhanced Diminishing Manufacturing** Sources (DMS) Support
- **Enhanced Product Change Notification**
- Qualification Pedigree[†]
- **Member of the Texas Instruments** Widebus™ Family
- Inputs Are TTL-Voltage Compatible
- 3-State Bus Driving True Outputs
- Flow-Through Architecture Optimizes **PCB Layout**
- Distributed V_{CC} and GND Pins Minimize **High-Speed Switching Noise**

description

SN74ACT16374Q-EP is 16-bit а edge-triggered D-type flip-flop with 3-state outputs, designed specifically for driving highly capacitive or relatively low-impedance loads. It is particularly suitable for implementing buffer registers, I/O ports, bidirectional bus drivers, and working registers.

This device can be used as two 8-bit flip-flops or one 16-bit flip-flop. On the positive transition of the clock (CLK) input, the Q outputs of the flip-flop take on the logic levels set up at the data (D) inputs.

An output-enable (OE) input can be used to place the outputs in either a normal logic state (high or low logic levels) or the high-impedance state. In the high-impedance state, the outputs neither load nor drive the bus lines significantly. The high-impedance state provides the capability to drive bus lines in a bus-organized system, without need for interface or pullup components. OE does not affect the internal operations of the flip-flop. Old data can be retained or new data can be entered while the outputs are in the high-impedance state.

ORDERING INFORMATION

TA	PACK	\GE [‡]	ORDERABLE PART NUMBER	TOP-SIDE MARKING
-40°C to 125°C	SSOP - DL	Tape and reel	SN74ACT16374QDLREP	ACT16374QEP

[‡] Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.

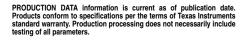


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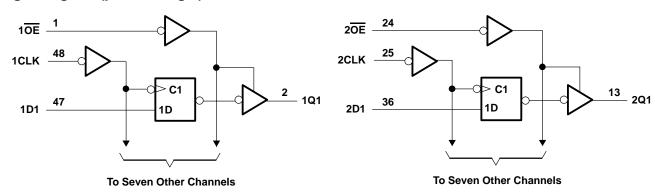
[†] Component qualification in accordance with JEDEC and industry standards to ensure reliable operation over an extended temperature range. This includes, but is not limited to, highly accelerated stress test (HAST) or biased 85/85, temperature cycle, autoclave or unbiased HAST, electromigration, bond intermetallic life, and mold compound life.

SCAS679B - MAY 2002 - REVISED JULY 2002

FUNCTION TABLE (each section)

	INPUTS	OUTPUT	
0E	CLK	D	Q
L	1	Н	Н
L	\uparrow	L	L
L	H or L	Χ	Q_0
Н	Χ	Χ	Z

logic diagram (positive logic)



absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage range, V _{CC}	–0.5 V to 7 V
Input voltage range, V _I (see Note 1)	–0.5 V to V _{CC} + 0.5 V
Output voltage range, V _O (see Note 1)	$-0.5 \text{ V to V}_{CC} + 0.5 \text{ V}$
Input clamp current, I_{IK} ($V_I < 0$ or $V_I > V_{CC}$)	±20 mA
Output clamp current, I _{OK} (V _O < 0 or V _O > V _{CC})	±24 mA
Continuous output current, I_O ($V_O = 0$ to V_{CC})	±24 mA
Continuous current through V _{CC} or GND	±260 mA
Maximum power dissipation at $T_A = 55^{\circ}C$ (in still air) (see Note 2): DL package	1.2 W
Storage temperature range, T _{stg}	–65°C to 150°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

- NOTES: 1. The input and output voltage ratings may be exceeded if the input and output current ratings are observed.
 - 2. The maximum package power dissipation is calculated using a junction temperature of 150°C and a board trace length of 750 mils.



SN74ACT16374Q-EP 16-BIT D-TYPE EDGE-TRIGGERED FLIP-FLOP WITH 3-STATE OUTPUTS

SCAS679B - MAY 2002 - REVISED JULY 2002

recommended operating conditions (see Note 3)

		MIN	NOM	MAX	UNIT
Vcc	Supply voltage (see Note 4)	4.5	5	5.5	V
VIH	High-level input voltage	2			V
VIL	Low-level input voltage			0.8	V
٧ _I	Input voltage	0		VCC	V
٧o	Output voltage	0		VCC	V
ЮН	High-level output current			-16	mA
loL	Low-level output current			16	mA
Δt/Δν	Input transition rise or fall rate	0		10	ns/V
TA	Operating free-air temperature	-40		125	°C

NOTES: 3. All unused inputs of the device must be at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, *Implications of Slow or Floating CMOS Inputs*, literature number SCBA004.

4. All V_{CC} and GND pins must be connected to the proper-voltage power supply.

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS		T,	4 = 25°C	;	MIN	MAX	UNIT
PARAMETER			MIN	TYP	MAX	IVIIIV		UNIT
	L 50 A		4.4			4.4		
	I _{OH} = -50 μA	5.5 V	5.4			5.4		
VoH	I _{OH} = -16 mA	4.5 V	3.94			3.7		V
	IOH = 10 IIIA	5.5 V	4.94			4.7		
	$I_{OH} = -24 \text{ mA}^{\dagger}$	5.5 V				3.85		
	Ι _{ΟL} = 50 μΑ	4.5 V			0.1		0.1	
	10L = 30 μΛ				0.1		0.1	V
V _{OL}	I _{OL} = 16 mA				0.36		0.5	
	IOL - 10 IIIA	5.5 V			0.36		0.5	
	$I_{OL} = 24 \text{ mA}^{\dagger}$	5.5 V					0.5	
lį	$V_I = V_{CC}$ or GND	5.5 V			±0.1		±1	μΑ
loz	$V_O = V_{CC}$ or GND	5.5 V			±0.5		±10	μΑ
Icc	$V_I = V_{CC}$ or GND, $I_O = 0$	5.5 V			8		160	μΑ
Δl _{CC} ‡	One input at 3.4 V, Other inputs at GND or V _{CC}	5.5 V			0.9		1	mA
C _i	$V_I = V_{CC}$ or GND	5 V	·	4.5	·			pF
Co	$V_O = V_{CC}$ or GND	5 V		12				pF

T Not more than one output should be tested at a time, and the duration of the test should not exceed 10 ms.



[‡] This is the increase in supply current for each input that is at one of the specified TTL-voltage levels rather than 0 V to V_{CC}.

SN74ACT16374Q-EP 16-BIT D-TYPE EDGE-TRIGGERED FLIP-FLOP WITH 3-STATE OUTPUTS

SCAS679B - MAY 2002 - REVISED JULY 2002

timing requirements over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see Figure 1)

			T _A = :	25°C	MIN	MAX	UNIT
		MIN	MAX	IVIIIN	WAA	UNIT	
fclock	Clock frequency		0	65	0	65	MHz
	Pulse duration	CLK low	7.5		7.5		no
t _W	ruise duration	4.5		4.5		ns	
t _{su}	Setup time, data before CLK↑		6.5		6.5		ns
t _h	Hold time, data after CLK↑		1		1		ns

switching characteristics over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see Figure 1)

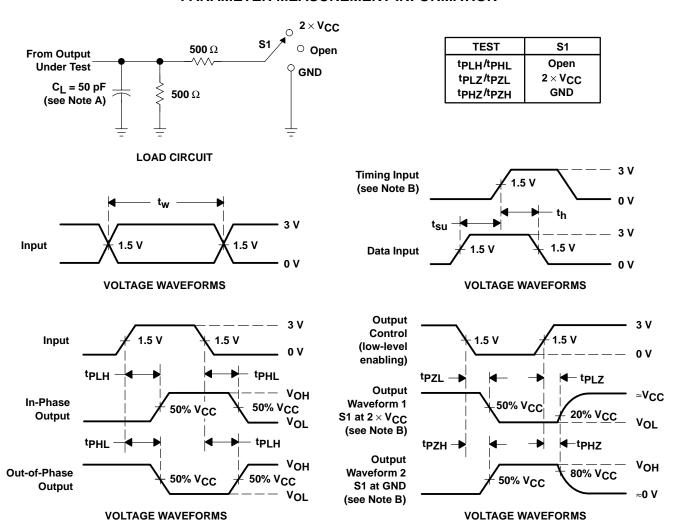
PARAMETER	FROM	то	T _A = 25°C			MIN	MAX	UNIT
PARAMETER	(INPUT)	(OUTPUT)	MIN	TYP	MAX	IVIIIV	IVIAA	UNIT
f _{max}			65			65		MHz
t _{PLH}	CLK	Q	5.1	8.8	10.9	5.1	13.2	20
^t PHL	CLK	Q [8.8	10.9	5.3	13.1	ns
^t PZH	ŌĒ	Q	3.7	8.4	10.5	3.7	12.7	ns
^t PZL	OE	ď		9.7	11.9	4.4	14.3	115
^t PHZ	ŌĒ	Q	5.4	7.9	9.8	5.4	10.9	ne
t _{PLZ}	OE .	γ	4.9	7.2	9.1	4.9	10.2	ns

operating characteristics, $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$

PARAMETER			TEST CO	TYP	UNIT	
C _{pd}	Dower dissipation conscitance per flip flep	Outputs enabled	$C_1 = 50 pF$	f = 1 MHz	52	pF
	Power dissipation capacitance per flip-flop	Outputs disabled	CL = 50 pr,		38	



PARAMETER MEASUREMENT INFORMATION



NOTES: A. C_L includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR \leq 1 MHz, $Z_O = 50 \ \Omega$, $t_f = 3 \ ns$, $t_f = 3 \ ns$.
- D. The outputs are measured one at a time with one input transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms





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PACKAGING INFORMATION

Orderable Device	Status ⁽¹⁾	Package Type	Package Drawing	Pins	Package Qty	Eco Plan ⁽²⁾	Lead/Ball Finish	MSL Peak Temp ⁽³⁾
SN74ACT16374QDLREP	ACTIVE	SSOP	DL	48	1000	TBD	Call TI	Level-1-235C-UNLIM
V62/03603-01XE	ACTIVE	SSOP	DL	48	1000	TBD	Call TI	Level-1-235C-UNLIM

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in

a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS) or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

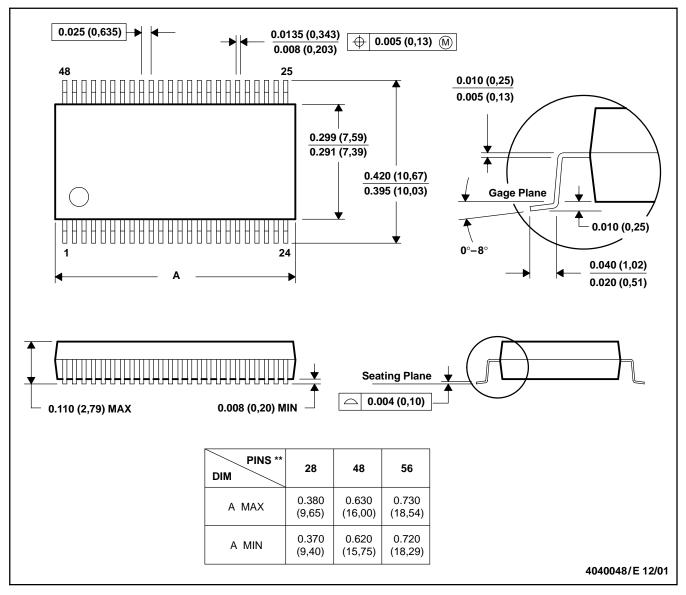
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DL (R-PDSO-G**)

48 PINS SHOWN

PLASTIC SMALL-OUTLINE PACKAGE



NOTES: A. All linear dimensions are in inches (millimeters).

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).

D. Falls within JEDEC MO-118

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